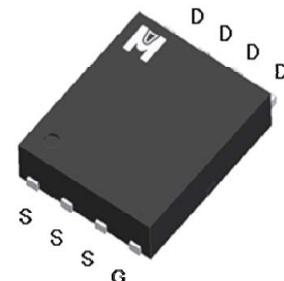
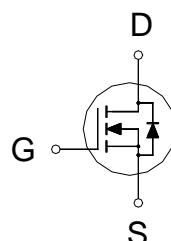


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

| | |
|---------------------|-----|
| BV_{DSS} | 30V |
| $R_{DS(on)}$ (MAX.) | 6mΩ |
| I_D | 75A |



UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ C$ Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS | | SYMBOL | LIMITS | UNIT |
|--|------------------------------------|----------------|------------|------|
| Gate-Source Voltage | | V_{GS} | ±20 | V |
| Continuous Drain Current | $T_c = 25^\circ C$ | I_D | 75 | A |
| | $T_c = 100^\circ C$ | | 45 | |
| Pulsed Drain Current ¹ | | I_{DM} | 160 | |
| Avalanche Current | | I_{AS} | 53 | |
| Avalanche Energy | $L = 0.1mH, I_D=53A, R_G=25\Omega$ | E_{AS} | 140 | mJ |
| Repetitive Avalanche Energy ² | $L = 0.05mH$ | E_{AR} | 40 | |
| Power Dissipation | $T_c = 25^\circ C$ | P_D | 50 | W |
| | $T_c = 100^\circ C$ | | 26 | |
| Operating Junction & Storage Temperature Range | | T_j, T_{stg} | -55 to 150 | °C |

100% UIS testing in condition of $V_D=15V$, $L=0.1mH$, $V_G=10V$, $I_L=40A$, Rated $V_{DS}=30V$ N-CH

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE | SYMBOL | TYPICAL | MAXIMUM | UNIT |
|---------------------|-----------|---------|---------|--------|
| Junction-to-Case | $R_{θJC}$ | | 2.5 | °C / W |
| Junction-to-Ambient | $R_{θJA}$ | | 50 | |

¹Pulse width limited by maximum junction temperature.

²Duty cycle ≤ 1%

³50°C / W when mounted on a 1 in² pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, Unless Otherwise Noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | LIMITS | | | UNIT |
|---|-----------------------------|---|--------|------|-----------|------------------|
| | | | MIN | TYP | MAX | |
| STATIC | | | | | | |
| Drain-Source Breakdown Voltage | $V_{(\text{BR})\text{DSS}}$ | $V_{GS} = 0V, I_D = 250\mu\text{A}$ | 30 | | | V |
| Gate Threshold Voltage | $V_{GS(\text{th})}$ | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ | 1 | 1.5 | 3 | |
| Gate-Body Leakage | I_{GSS} | $V_{DS} = 0V, V_{GS} = \pm 20V$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 24V, V_{GS} = 0V$ | | | 1 | μA |
| | | $V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ | | | 25 | |
| On-State Drain Current ¹ | $I_{D(\text{ON})}$ | $V_{DS} = 10V, V_{GS} = 10V$ | 75 | | | A |
| Drain-Source On-State Resistance ¹ | $R_{DS(\text{ON})}$ | $V_{GS} = 10V, I_D = 30\text{A}$ | | 5.3 | 6 | $\text{m}\Omega$ |
| | | $V_{GS} = 4.5V, I_D = 20\text{A}$ | | 7.5 | 9.5 | |
| Forward Transconductance ¹ | g_{fs} | $V_{DS} = 5V, I_D = 24\text{A}$ | | 25 | | S |
| DYNAMIC | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0V, V_{DS} = 15V, f = 1\text{MHz}$ | | 2040 | | pF |
| Output Capacitance | C_{oss} | | | 288 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 158 | | |
| Gate Resistance | R_g | $V_{GS} = 15\text{mV}, V_{DS} = 0V, f = 1\text{MHz}$ | | 2.2 | | Ω |
| Total Gate Charge ^{1,2} | $Q_g(V_{GS}=10V)$ | $V_{DS} = 15V, V_{GS} = 10V,$ $I_D = 30\text{A}$ | | 31.7 | | nC |
| | $Q_g(V_{GS}=4.5V)$ | | | 16 | | |
| Gate-Source Charge ^{1,2} | Q_{gs} | | | 3.3 | | |
| Gate-Drain Charge ^{1,2} | Q_{gd} | | | 7 | | |
| Turn-On Delay Time ^{1,2} | $t_{d(\text{on})}$ | $V_{DS} = 15V,$ $I_D = 24\text{A}, V_{GS} = 10V, R_{GS} = 2.7\Omega$ | | 10 | | nS |
| Rise Time ^{1,2} | t_r | | | 15 | | |
| Turn-Off Delay Time ^{1,2} | $t_{d(\text{off})}$ | | | 30 | | |
| Fall Time ^{1,2} | t_f | | | 15 | | |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ\text{C}$) | | | | | | |
| Continuous Current | I_S | $I_F = I_S, V_{GS} = 0V$ | | | 75 | A |
| Pulsed Current ³ | I_{SM} | | | | 150 | |
| Forward Voltage ¹ | V_{SD} | | | | 1.3 | |
| Reverse Recovery Time | t_{rr} | | | 32 | | |
| Peak Reverse Recovery Current | $I_{RM(\text{REC})}$ | | | 200 | | |
| Reverse Recovery Charge | Q_{rr} | | | 12 | | |

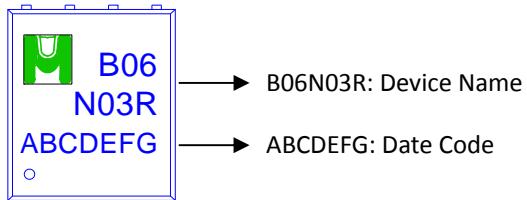
¹Pulse test : Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

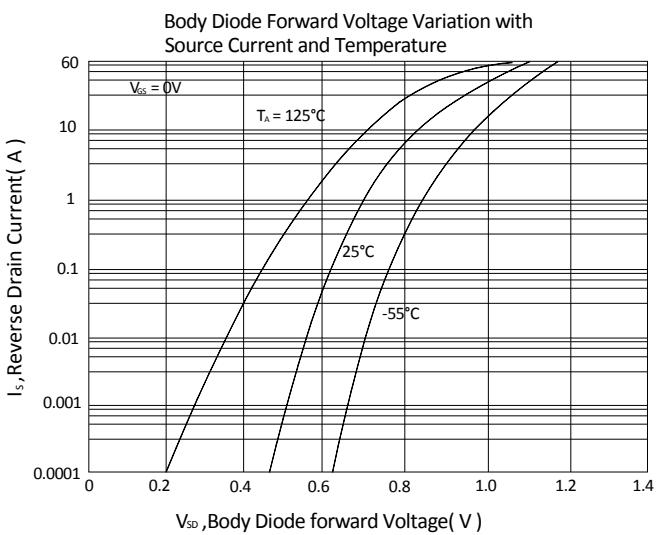
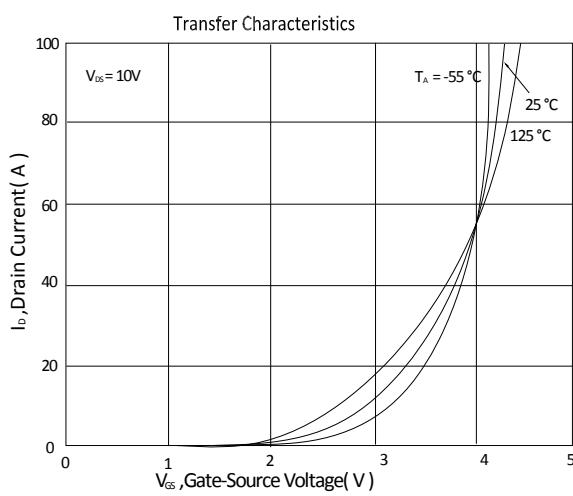
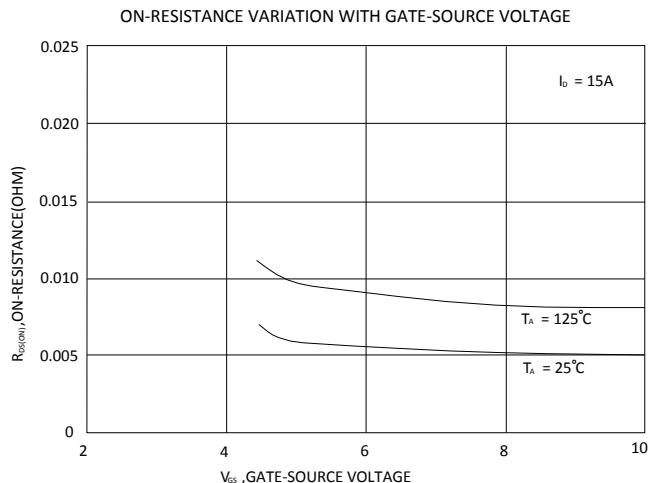
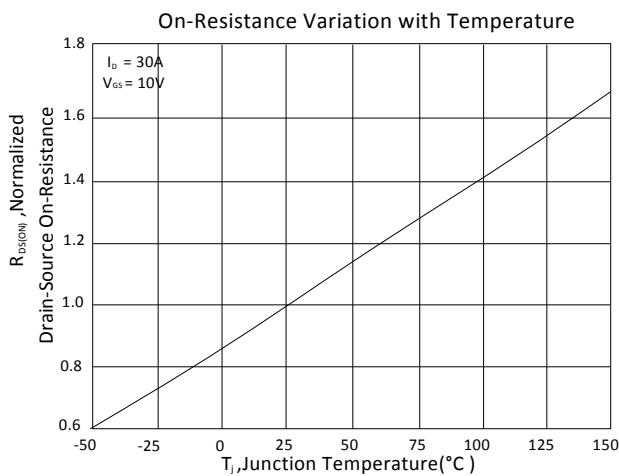
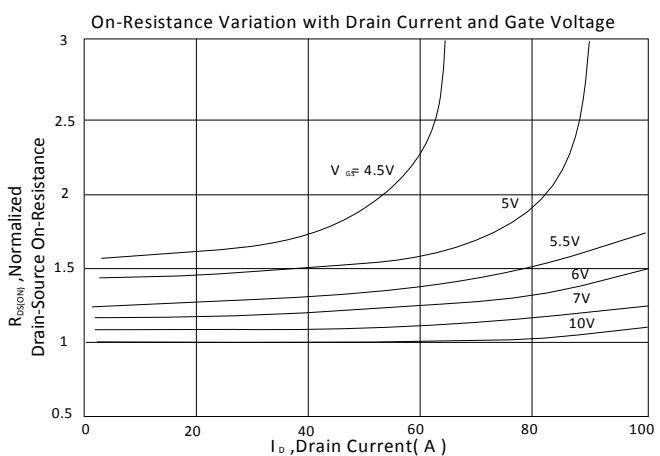
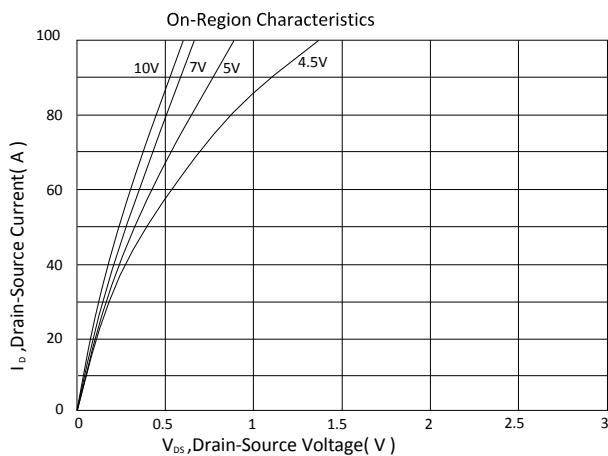
³Pulse width limited by maximum junction temperature.

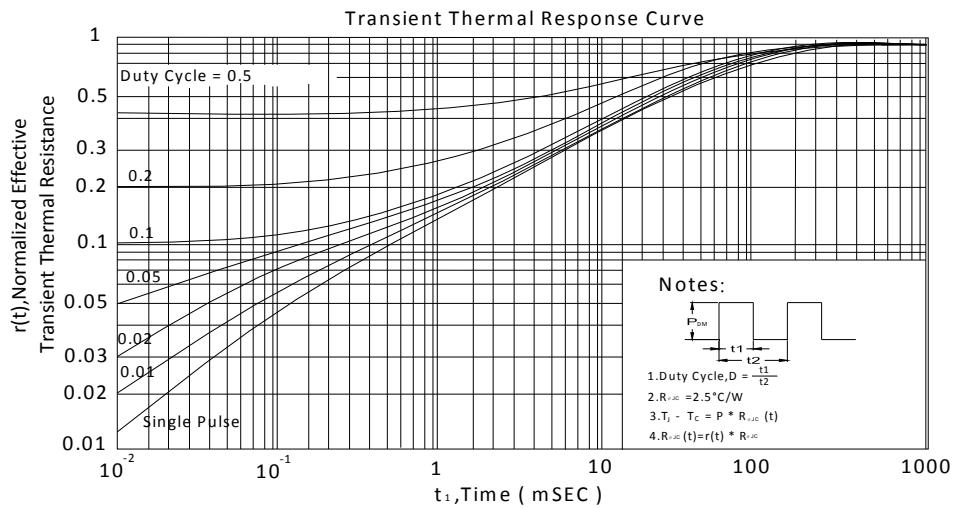
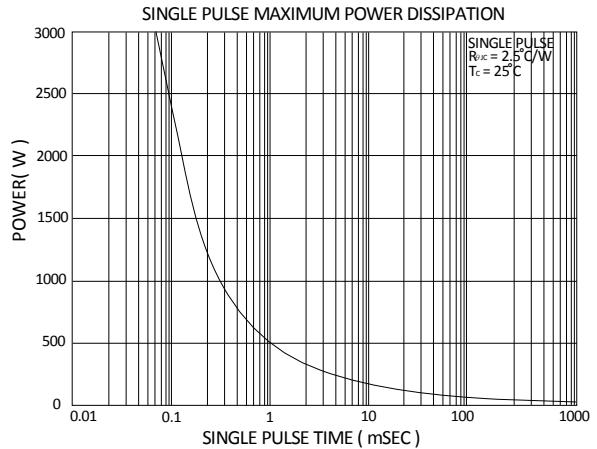
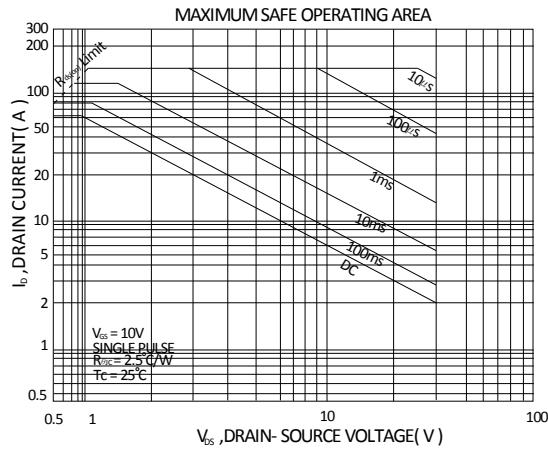
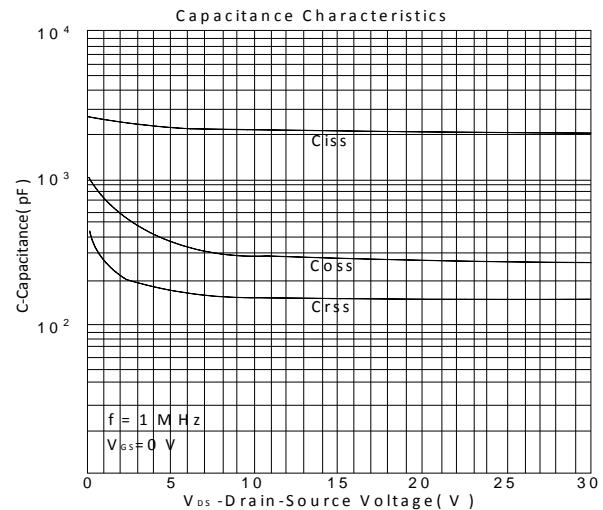
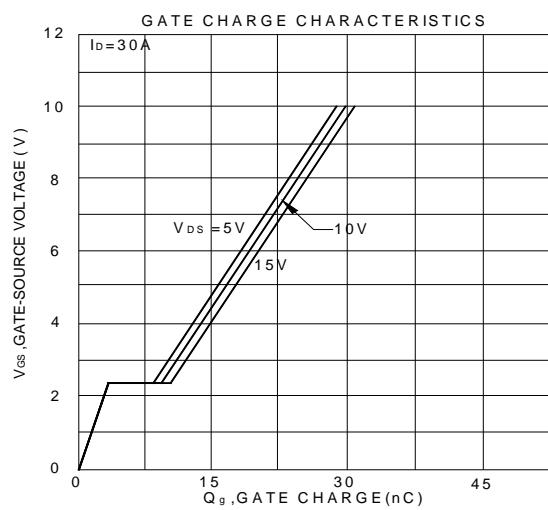
Ordering & Marking Information:

Device Name: EMB06N03HR for EDFN 5 x 6

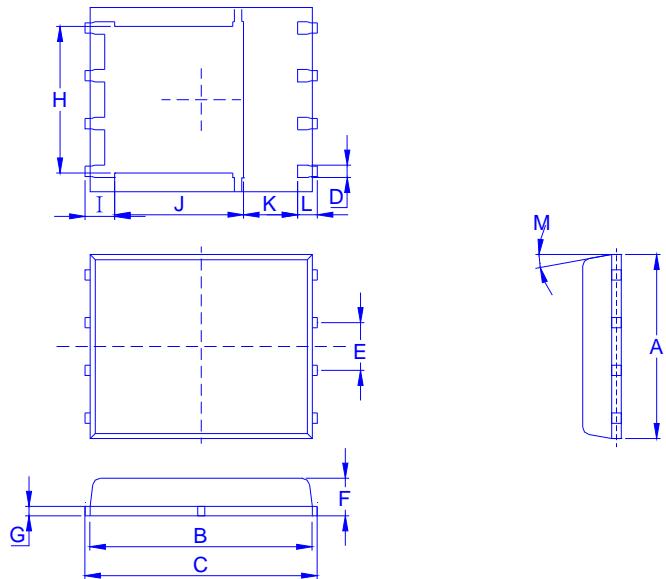


TYPICAL CHARACTERISTICS





Outline Drawing



Dimension in mm

| Dimension | A | B | C | D | E | F | G | H | I | J | K | L | M |
|-----------|------|------|------|------|------|------|------|------|------|------|------|------|-----|
| Min. | 4.80 | 5.50 | 5.90 | 0.3 | | 0.85 | 0.15 | 3.67 | 0.41 | 3.00 | 0.94 | 0.45 | 0° |
| Typ. | | | | | 1.27 | | | | | | | | |
| Max. | 5.30 | 5.90 | 6.15 | 0.51 | | 1.20 | 0.30 | 4.54 | 0.85 | 3.92 | 1.7 | 0.71 | 12° |

Recommended minimum pads

